International

- Logic-Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS (5)
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free

Description

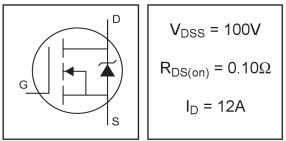
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

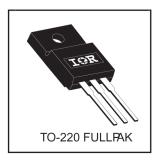
The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

Absolute Maximum Ratings

PD - 95635

HEXFET[®] Power MOSFET





	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	12	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	8.6	A
I _{DM}	Pulsed Drain Current ①⑥	60	
P _D @T _C = 25°C	Power Dissipation	41	W
	Linear Derating Factor	0.27	W/°C
V _{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy@6	150	mJ
I _{AR}	Avalanche Current①⑥	9.0	A
E _{AR}	Repetitive Avalanche Energy①	4.1	mJ
dv/dt	Peak Diode Recovery dv/dt 36	5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		3.7	0000
$R_{\theta JA}$	Junction-to-Ambient		65	°C/W

IRLI530NPbF

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	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	V_{GS} = 0V, I _D = 250µA	
$\Delta V_{(BR)DSS}\!/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.122		V/°C	Reference to 25°C, I _D = 1mA⑥	
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.100	Ω	V _{GS} = 10V, I _D = 9.0A ④	
				0.120		V _{GS} = 5.0V, I _D = 9.0A ④	
				0.150		V _{GS} = 4.0V, I _D = 8.0A ④	
V _{GS(th)}	Gate Threshold Voltage	1.0		2.0	V	V_{DS} = V_{GS} , I_D = 250 μ A	
g _{fs}	Forward Transconductance	7.7			S	V _{DS} = 50V, I _D = 9.0A⑥	
1	Drain to Course Lookana Current			25		V _{DS} = 100V, V _{GS} = 0V	
DSS	Drain-to-Source Leakage Current			250	μA	V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150°C	
I	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V	
I _{GSS}	Gate-to-Source Reverse Leakage			-100		V _{GS} = -16V	
Qg	Total Gate Charge			34		I _D = 9.0A	
Q _{gs}	Gate-to-Source Charge			4.8	nC	V _{DS} = 80V	
Q _{gd}	Gate-to-Drain ("Miller") Charge			20	1	V_{GS} = 5.0V, See Fig. 6 and 13 \oplus 6	
t _{d(on)}	Turn-On Delay Time		7.2			V _{DD} = 50V	
tr	Rise Time		53		ns	I _D = 9.0A	
t _{d(off)}	Turn-Off Delay Time		30		115	R _G = 6.0Ω, V _{GS} = 5.0V	
t _f	Fall Time		26			R _D = 5.5Ω, See Fig. 10 ④ ⑥	
	Internet Durin Industrians		4.5			Between lead,	
L _D	Internal Drain Inductance		4.5 —				6mm (0.25in.)
1	Internel Course Inductores	7.5	7.5		_ nH	from package 🔍 🕂	
L _S	Internal Source Inductance		—		and center of die contact		
C _{iss}	Input Capacitance		800			V _{GS} = 0V	
Coss	Output Capacitance		160		pF	V _{DS} = 25V	
C _{rss}	Reverse Transfer Capacitance		90			f = 1.0MHz, See Fig. 5©	
С	Drain to Sink Capacitance		12		1	f = 1.0MHz	
	-		1	I	1		

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
I _S	Continuous Source Current	purce Current		10		MOSFET symbol	
	(Body Diode)		- 12	A	showing the		
I _{SM}	Pulsed Source Current						integral reverse 🔬 🕁
	(Body Diode) ①⑥		60		p-n junction diode.		
V _{SD}	Diode Forward Voltage			1.3	V	T_J = 25°C, I_S = 6.6A, V_{GS} = 0V ④	
t _{rr}	Reverse Recovery Time		140	210	ns	T _J = 25°C, I _F = 9.0A	
Q _{rr}	Reverse RecoveryCharge		740	1100	nC	di/dt = 100A/µs ⊛	
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)					

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Starting $T_J = 25^{\circ}C$, L = 3.1mH

 $R_G = 25\Omega$, $I_{AS} = 9.0A$. (See Figure 12)

④ Pulse width \leq 300µs; duty cycle \leq 2%.

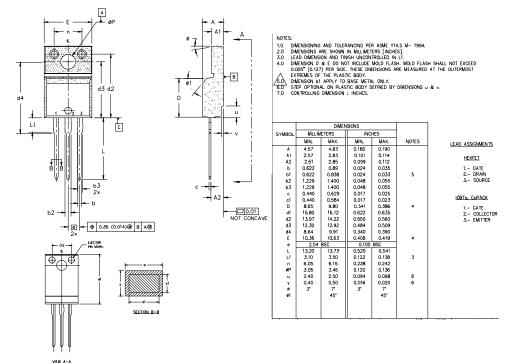
⑤ t=60s, f=60Hz

 $\label{eq:ISD} \textcircled{3} I_{SD} \leq 9.0A, \ di/dt \leq 540A/\mu s, \ V_{DD} \leq V_{(BR)DSS},$ $T_J \le 175^{\circ}C$

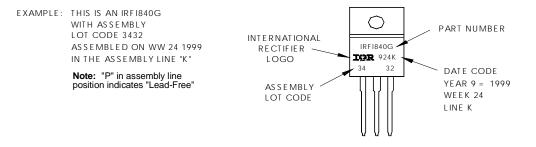
IRLI530NPbF

TO-220 Full-Pak Package Outline

Dimensions are shown in millimeters (inches)



TO-220 Full-Pak Part Marking Information



Data and specifications subject to change without notice.

International

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